

Notice of References Cited	Application/Control No. 10/788,667		Applicant(s)/Patent Under Reexamination FERIANZ ET AL.	
	Examiner Hiep Nguyen		Art Unit 2816	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,224,671	09-1980	Sugiyama et al.	702/60
*	B	US-6,166,596	12-2000	Higashiyama et al.	330/10
*	C	US-6,441,866	08-2002	Chen et al.	348/606
*	D	US-6,480,067	11-2002	Kobayashi et al.	330/279
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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